Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/591,135	ITOU ET AL.	•
Examiner	Art Unit	
Eduardo Colon Santana	2837	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			<u> </u>	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST SEARCH plus TEXT SEARCH INCLUDING EPO, JPO AND DERWERT DATABASES	12/20/2007	ECS	
TEXT SEARCH VARIOUS CLASS SEE ATTACHMENT	12/20/2007	ECS	
PLUS SEARCH DONE BY 2800 EIC	12/21/2007	ECS	